

# **FDS7764A**

# 30V N-Channel PowerTrench® MOSFET

### **General Description**

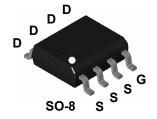
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{\text{DS(ON)}}$  in a small package.

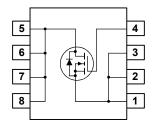
### **Applications**

- · Synchronous rectifier
- DC/DC converter

#### **Features**

- 15 A, 30 V.  $R_{DS(ON)} = 7.5 \text{ m}\Omega \text{ @ } V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low R<sub>DS(ON)</sub>. High power and current handling capability





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Symbol                            | Parameter                                  |            | Ratings     | Units |
|-----------------------------------|--|------------|-------------|-------|
| $V_{DSS}$                         | Drain-Source Voltage                       |            | 30          | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                        |            | ±12         | V     |
| I <sub>D</sub>                    | Drain Current - Continuous                 | (Note 1a)  | 15          | Α     |
|                                   | - Pulsed                                   |            | 50          |       |
| P <sub>D</sub>                    | Power Dissipation for Single Operation     | (Note 1a)  | 2.5         | W     |
|                                   |  | (Note 1b)  | 1.2         |       |
|                                   |  | (Note 1c)  | 1.0         |       |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperation | ture Range | -55 to +150 | °C    |

### **Thermal Characteristics**

|                  |   |           | _  |      |
|------------------|---|-----------|----|------|
| $R_{\theta JA}$  | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 50 | °C/W |
| R <sub>θJC</sub> | Thermal Resistance, Junction-to-Case    | (Note 1)  | 30 | °C/W |

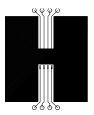
### **Package Marking and Ordering Information**

| Device Marking | Device   | Reel Size | Tape width | Quantity   |
|----------------|----------|-----------|------------|------------|
| FDS7764A       | FDS7764A | 13"       | 12mm       | 2500 units |

| Symbol                                 | Parameter   | Test Conditions  | Min | Тур               | Max       | Units |
|--|---|--|-----|-------------------|-----------|-------|
| Off Char                               | acteristics                                       |  |     |                   |           |       |
| BV <sub>DSS</sub>                      | Drain–Source Breakdown Voltage                    | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$  | 30  |                   |           | V     |
| ΔBV <sub>DSS</sub><br>ΔT <sub>J</sub>  | Breakdown Voltage Temperature Coefficient         | $I_D$ = 250 μA, Referenced to 25°C   |     | 23                |           | mV/°C |
| I <sub>DSS</sub>                       | Zero Gate Voltage Drain Current                   | V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V  |     |                   | 1         | μА    |
| I <sub>GSSF</sub>                      | Gate–Body Leakage, Forward                        | V <sub>GS</sub> = 12 V, V <sub>DS</sub> = 0 V  |     |                   | 100       | nA    |
| I <sub>GSSR</sub>                      | Gate–Body Leakage, Reverse                        | V <sub>GS</sub> = -12 V, V <sub>DS</sub> = 0 V   |     |                   | -100      | nA    |
| On Char                                | acteristics (Note 2)                              |  |     |                   | •         |       |
| $V_{GS(th)}$                           | Gate Threshold Voltage                            | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$   | 0.8 | 1.1               | 2.0       | V     |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage<br>Temperature Coefficient | $I_D$ = 250 $\mu$ A, Referenced to 25°C  |     | -4                |           | mV/°C |
| R <sub>DS(on)</sub>                    | Static Drain–Source<br>On–Resistance              | $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$<br>$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}, T_J = 125^{\circ}\text{C}$<br>$V_{GS} = 10 \text{ V}, I_D = 15.5 \text{ A}$ |     | 6.5<br>9.3<br>6.0 | 7.5<br>13 | mΩ    |
| I <sub>D(on)</sub>                     | On–State Drain Current                            | $V_{GS} = 10 \text{ V}, I_D = 15.5 \text{ A}$<br>$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$  | 25  |                   |           | Α     |
| g <sub>FS</sub>                        | Forward Transconductance                          | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A  |     | 97                |           | S     |
| Dynamic                                | : Characteristics                                 |  |     |                   |           |       |
| C <sub>iss</sub>                       | Input Capacitance                                 | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,   |     | 3451              |           | pF    |
| C <sub>oss</sub>                       | Output Capacitance                                | f = 1.0 MHz  |     | 520               |           | pF    |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance                      |  |     | 202               |           | pF    |
| Switchin                               | g Characteristics (Note 2)                        |  |     |                   |           |       |
| t <sub>d(on)</sub>                     | Turn-On Delay Time                                | $V_{DD} = 15 \text{ V},  I_D = 1 \text{ A},$   |     | 16                | 28        | ns    |
| t <sub>r</sub>                         | Turn-On Rise Time                                 | $V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$   |     | 13                | 23        | ns    |
| $t_{d(off)}$                           | Turn-Off Delay Time                               |  |     | 52                | 82        | ns    |
| t <sub>f</sub>                         | Turn–Off Fall Time                                |  |     | 20                | 36        | ns    |
| Q <sub>g</sub>                         | Total Gate Charge                                 | $V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$   |     | 29                | 40        | nC    |
| Q <sub>gs</sub>                        | Gate-Source Charge                                | V <sub>GS</sub> = 4.5 V  |     | 6.7               |           | nC    |
| $Q_{gd}$                               | Gate-Drain Charge                                 |  |     | 7                 |           | nC    |
| Drain-S                                | ource Diode Characteristics                       | and Maximum Ratings  |     |                   |           |       |
| Is                                     | Maximum Continuous Drain-Source                   |  |     |                   | 2.1       | Α     |
| $V_{\text{SD}}$                        | Drain–Source Diode Forward<br>Voltage             | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.1 A (Note 2)   |     | 0.7               | 1.2       | V     |
| $t_{RR}$                               | Reverse Recovery Time                             | I <sub>F</sub> = 15 A  |     | 28                |           | ns    |
| $Q_{RR}$                               | Reverse Recovery Charge                           | $di_F/dt = 100 A/us$   |     | 16                |           | nC    |

#### Notes

<sup>1.</sup>  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.



a) 50°C/W when mounted on a 1in² pad of 2 oz copper



b) 105°C/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper



c) 125°C/W when mounted on a minimum pad.

Scale 1: 1 on letter size paper

**2.** Pulse Test: Pulse Width <  $300\mu$ s, Duty Cycle < 2.0%

# **Typical Characteristics**

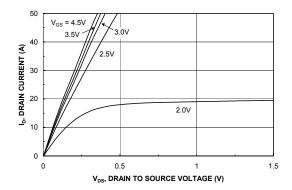


Figure 1. On-Region Characteristics.

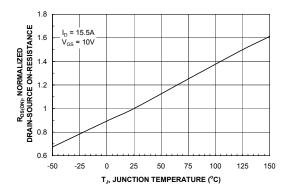


Figure 3. On-Resistance Variation with Temperature.

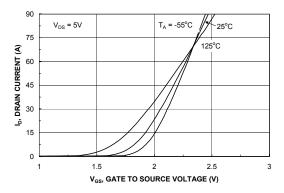


Figure 5. Transfer Characteristics.

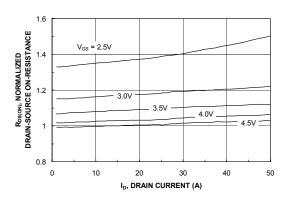


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

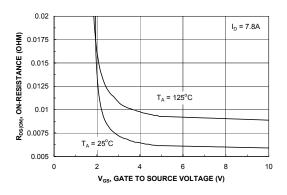


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

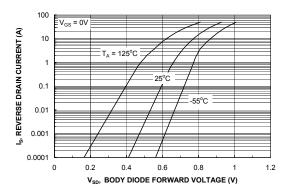
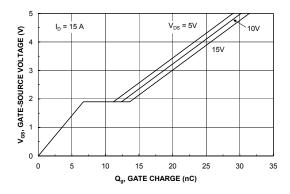


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



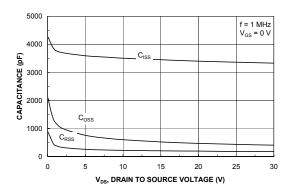


Figure 7. Gate Charge Characteristics.

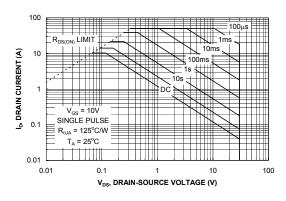


Figure 8. Capacitance Characteristics.

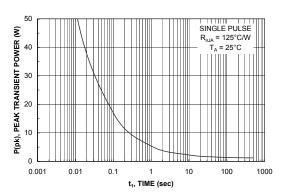


Figure 9. Maximum Safe Operating Area.



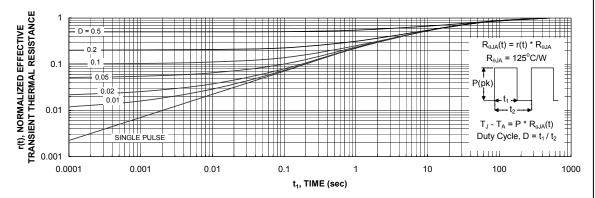


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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| CoolFET™                          | FRFET™                         | MICROCOUPLER™     | PowerSaver™         | SuperSOT™-3            |
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| DOME™                             | GTO™ .                         | MicroPak™         | QFET®               | SuperSOT™-8            |
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